

NC7WZ132

TinyLogic™ UHS Dual 2-Input NAND Gate with Schmitt Trigger Inputs

General Description

The NC7WZ132 is a dual 2-Input NAND Gate from Fairchild's Ultra High Speed Series of TinyLogic™. The device is fabricated with advanced CMOS technology to achieve ultra high speed with high output drive while maintaining low static power dissipation over a broad V_{CC} operating range. The device is specified to operate over the 1.65V to 5.5V V_{CC} operating range. The inputs and output are high impedance when V_{CC} is 0V. Inputs tolerate voltages up to 7V independent of V_{CC} operating voltage. Schmitt trigger inputs achieve typically 1V hysteresis between the positive-going and negative-going input threshold voltage at 5V V_{CC} .

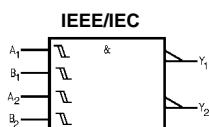
Features

- Space saving US8 surface mount package
- Ultra High Speed; t_{PD} 3.1 ns typ into 50 pF at 5V V_{CC}
- High Output Drive; ± 24 mA at 3V V_{CC}
- Broad V_{CC} Operating Range; 1.65V–5.5V
- Matches the performance of LCX when operated at 3.3V V_{CC}
- Power down high impedance inputs/output
- Overvoltage tolerant inputs facilitate 5V to 3V translation
- Patented noise/EMI reduction circuitry implemented
- Schmitt trigger inputs are tolerant of slow changing input signals

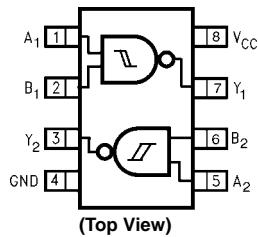
Ordering Code:

Order Number	Package Number	Product Code Top Mark	Package Description	Supplied As
NC7WZ132K8X	MAB08A	WZD2	8-Lead US8, JEDEC MO-187, Variation CA 3.1mm Wide	3k Units on Tape and Reel

Logic Symbol



Connection Diagrams



Pin Descriptions

Pin Names	Description
A_n, B_n	Inputs
Y_n	Output

Function Table

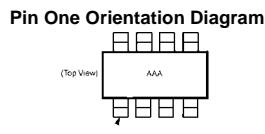
$$Y = \overline{AB}$$

Inputs		Output
A	B	Y
L	L	H
L	H	H
H	L	H
H	H	L

H = HIGH Logic Level

L = LOW Logic Level

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AAA represents Product Code Top Mark - see ordering code

Note: Orientation of Top Mark determines Pin One location. Read the top product code mark left to right, Pin One is the lower left pin (see diagram).

Absolute Maximum Ratings(Note 1)

Supply Voltage (V_{CC})	-0.5V to +7V
DC Input Voltage (V_{IN})	-0.5V to +7V
DC Output Voltage (V_{OUT})	-0.5V to +7V
DC Input Diode Current (I_{IK}) @ $V_{IN} < -0.5V$	-50 mA
DC Output Diode Current (I_{OK}) @ $V_{OUT} < -0.5V$	-50 mA
DC Output Current (I_{OUT})	\pm 50 mA
DC V_{CC}/GND Current (I_{CC}/I_{GND})	\pm 100 mA
Storage Temperature (T_{STG})	-65°C to +150°C
Junction Temperature under Bias (T_J)	150°C
Junction Lead Temperature (T_L); (Soldering, 10 seconds)	260°C
Power Dissipation (P_D) @ +85°C	250 mW

Recommended Operating Conditions (Note 2)

Supply Voltage Operating (V_{CC})	1.65V to 5.5V
Supply Voltage Data Retention (V_{CC})	1.5V to 5.5V
Input Voltage (V_{IN})	0V to 5.5V
Output Voltage (V_{OUT})	0V to V_{CC}
Operating Temperature (T_A)	-40°C to +85°C
Thermal Resistance (θ_{JA})	250°C/W

Note 1: Absolute maximum ratings are DC values beyond which the device may be damaged or have its useful life impaired. The datasheet specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature, and output/input loading variables. Fairchild does not recommend operation outside datasheet specifications.

Note 2: Unused inputs must be held HIGH or LOW. They may not float.

DC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	$T_A = +25^\circ C$			Units	Conditions
			Min	Typ	Max		
V_P	Positive Threshold Voltage	1.65	0.6	0.99	1.4	V	
		2.3	1.0	1.39	1.8		
		3.0	1.3	1.77	2.2		
		4.5	1.9	2.49	3.1		
		5.5	2.2	2.96	3.6		
V_N	Negative Threshold Voltage	1.65	0.2	0.53	0.9	V	
		2.3	0.4	0.78	1.15		
		3.0	0.6	1.02	1.5		
		4.5	1.0	1.48	2.0		
		5.5	1.2	1.76	2.3		
V_H	Hysteresis Voltage	1.65	0.15	0.46	0.9	V	
		2.3	0.25	0.61	1.1		
		3.0	0.4	0.75	1.2		
		4.5	0.6	1.01	1.5		
		5.5	0.7	1.20	1.7		
V_{OH}	HIGH Level Output Voltage	1.65	1.55	1.65	1.55	V	$V_{IN} = V_{IH}$ $I_{OH} = -100 \mu A$
		2.3	2.2	2.3	2.2		
		3.0	2.9	3.0	2.9		
		4.5	4.4	4.5	4.4		
		1.65	1.29	1.52	1.29		
		2.3	1.9	2.15	1.9	V	$I_{OH} = -4 mA$ $I_{OH} = -8 mA$ $I_{OH} = -16 mA$ $I_{OH} = -24 mA$ $I_{OH} = -32 mA$
		3.0	2.4	2.80	2.4		
		3.0	2.3	3.68	2.3		
		4.5	3.8	4.20	3.8		
		1.65	0.08	0.24	0.24		
V_{OL}	LOW Level Output Voltage	1.65	0.0	0.10	0.10	V	$V_{IN} = V_{IH}$ $I_{OL} = 100 \mu A$ $I_{OL} = 4 mA$ $I_{OL} = 8 mA$ $I_{OL} = 16 mA$ $I_{OL} = 24 mA$ $I_{OL} = 32 mA$
		2.3	0.0	0.10	0.10		
		3.0	0.0	0.10	0.10		
		4.5	0.0	0.10	0.10		
		1.65	0.08	0.24	0.24		
I_{IN}	Input Leakage Current	0-5.5	\pm 0.1		\pm 1	μA	$V_{IN} = 5.5V, GND$
	Power Off Leakage Current	0.0	1		10	μA	V_{IN} or $V_{OUT} = 5.5V$

DC Electrical Characteristics (Continued)

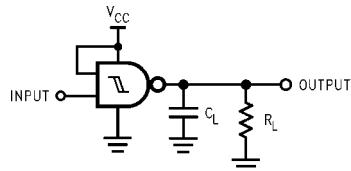
Symbol	Parameter	V_{CC} (V)	$T_A = +25^\circ C$			$T_A = -40^\circ C \text{ to } +85^\circ C$		Units	Conditions
			Min	Typ	Max	Min	Max		
I_{CC}	Quiescent Supply Current	1.65 to 5.5			1		10	μA	$V_{IN} = 5.5V, GND$

AC Electrical Characteristics

Symbol	Parameter	V_{CC} (V)	$T_A = +25^\circ C$			$T_A = -40^\circ C \text{ to } +85^\circ C$		Units	Conditions	Fig. No.
			Min	Typ	Max	Min	Max			
t_{PLH}, t_{PHL}	Propagation Delay	1.8 ± 0.15	3.0	7.1	13.0	3.0	13.5	ns	$C_L = 15 \text{ pF}, R_L = 1 \text{ M}\Omega$	Figures 1, 3
		2.5 ± 0.2	2.0	4.5	7.5	2.0	8.0			
		3.3 ± 0.3	1.2	3.4	5.0	1.2	5.5			
		5.0 ± 0.5	0.8	2.6	3.8	0.8	4.2			
t_{PLH}, t_{PHL}	Propagation Delay	3.3 ± 0.3	1.8	4.0	5.8	1.8	6.3	ns	$C_L = 50 \text{ pF}, R_L = 500\Omega$	Figures 1, 3
		5.0 ± 0.5	1.2	3.1	4.5	1.2	4.9			
C_{IN}	Input Capacitance	0		2.5				pF		
C_{PD}	Power Dissipation Capacitance	3.3		15				pF	(Note 3)	Figure 2
		5.0		18						

Note 3: C_{PD} is defined as the value of the internal equivalent capacitance which is derived from dynamic operating current consumption (I_{CCD}) at no output loading and operating at 50% duty cycle. (See Figure 2.) C_{PD} is related to I_{CCD} dynamic operating current by the expression:
 $I_{CCD} = (C_{PD})(V_{CC})(f_{IN}) + (I_{CC\text{static}})$

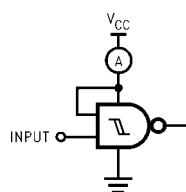
AC Loading and Waveforms



C_L includes load and stray capacitance

Input PRR = 1.0 MHz; $t_w = 500$ ns

FIGURE 1. AC Test Circuit



Input = AC Waveform; $t_r = t_f = 1.8$ ns;

PRR = 10 MHz; Duty Cycle = 50%

FIGURE 2. I_{CCD} Test Circuit

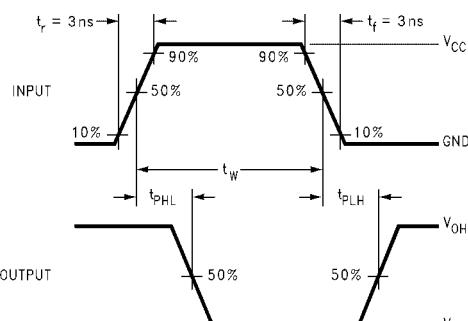


FIGURE 3. AC Waveforms

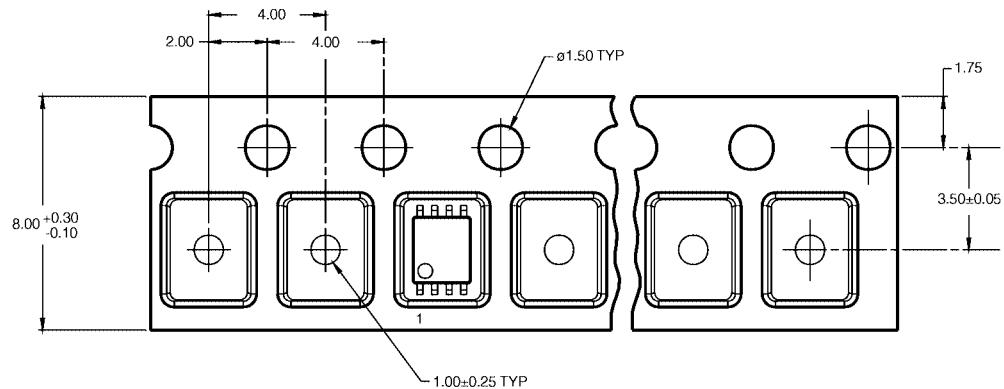
NC7WZ132

Tape and Reel Specification

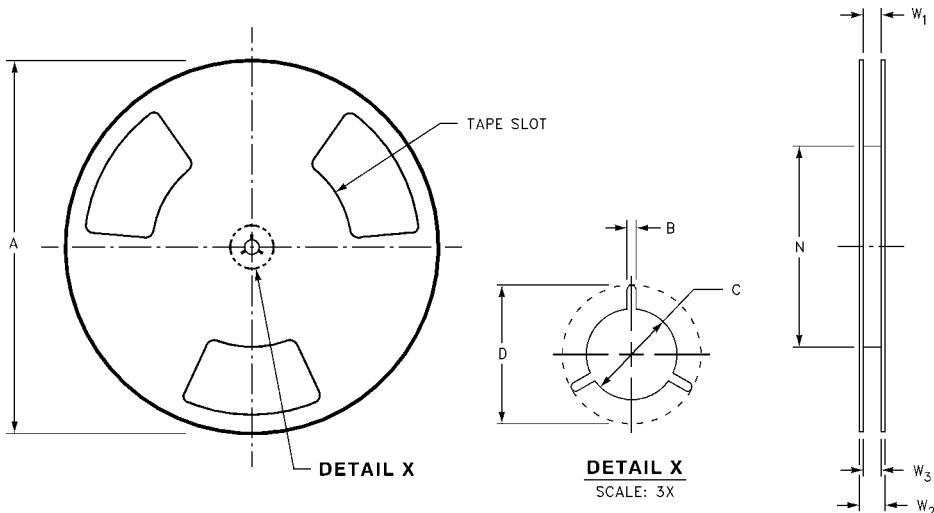
Tape Format

Package Designator	Tape Section	Number Cavities	Cavity Status	Cover Tape Status
K8X	Leader (Start End)	125 (typ)	Empty	Sealed
	Carrier	3000	Filled	Sealed
	Trailer (Hub End)	75 (typ)	Empty	Sealed

TAPE DIMENSIONS inches (millimeters)



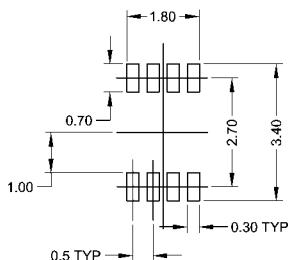
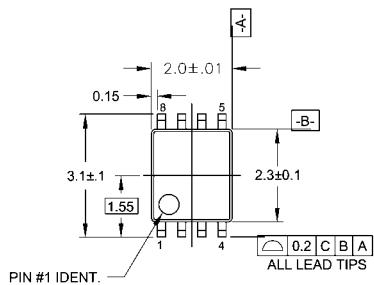
REEL DIMENSIONS inches (millimeters)



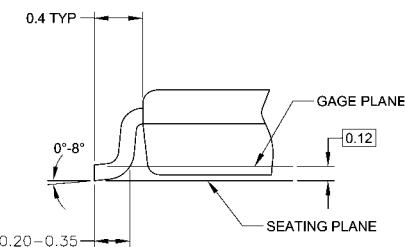
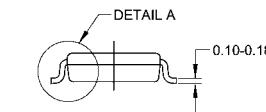
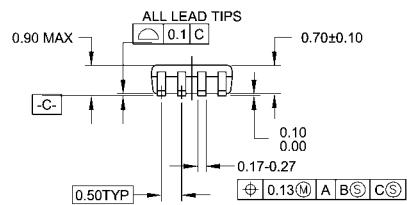
Tape Size	A	B	C	D	N	W1	W2	W3
8 mm	7.0 (177.8)	0.059 (1.50)	0.512 (13.00)	0.795 (20.20)	2.165 (55.00)	0.331 + 0.059/-0.000 (8.40 + 1.50/-0.00)	0.567 (14.40)	W1 + 0.078/-0.039 (W1 + 2.00/-1.00)

NCT7WZ132 TinyLogic™ UHS Dual 2-Input NAND Gate with Schmitt Trigger Inputs

Physical Dimensions inches (millimeters) unless otherwise noted



LAND PATTERN RECOMMENDATION



NOTES:

- A. CONFORMS TO JEDEC REGISTRATION MO-187
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- D. DIMENSIONS AND TOLERANCES PER ANSI Y14.5M, 1982.

DETAIL A

MAB08AREVC

**8-Lead US8, JEDEC MO-187, Variation CA 3.1mm Wide
Package Number MAB08A**

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